

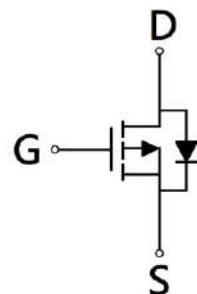
## P-Channel Enhancement Mode Power MOSFET

### Features

- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic

### Equivalent Circuit

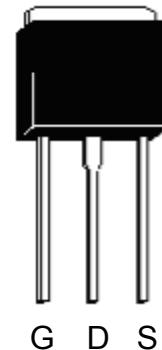
KIB060P06



G : Gate S : Source D : Drain

### Outline

TO-251



$BV_{DSS}$	-60V
$Id@V_{GS}=-10V, T_c=25^\circ C$	-14A
$Id@V_{GS}=-10V, T_a=25^\circ C$	-4.4A
$R_{DS(ON)} \text{ typ. } @ V_{GS}=-10V, Id=-4A$	66m $\Omega$
$R_{DS(ON)} \text{ typ. } @ V_{GS}=-4.5V, Id=-3A$	80m $\Omega$

### Ordering Information

Device	Package	Shipping
KIB060P06	TO-251 (Pb-free lead plating and halogen-free package)	80 pcs/tube, 50 tubes/box



### Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	-60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current @ $V_{GS}=-10\text{V}$ , $T_c=25^\circ\text{C}$	$I_D$	-14	A
Continuous Drain Current @ $V_{GS}=-10\text{V}$ , $T_c=100^\circ\text{C}$		-8.8	
Continuous Drain Current @ $V_{GS}=-10\text{V}$ , $T_A=25^\circ\text{C}$		-4.4	
Continuous Drain Current @ $V_{GS}=-10\text{V}$ , $T_A=70^\circ\text{C}$		-3.5	
Pulsed Drain Current	$I_{DM}$	-56	
Continuous Body Diode Forward Current @ $T_c=25^\circ\text{C}$	$I_S$	-14	
Pulsed Body Diode Forward Current @ $T_c=25^\circ\text{C}$	$I_{SM}$	-56	
Avalanche Current @ $L=0.1\text{mH}$	$I_{AS}$	-14	
Avalanche Energy @ $L=0.5\text{mH}$	$E_{AS}$	6	mJ
Total Power Dissipation	$T_c=25^\circ\text{C}$	*a 34	W
	$T_c=100^\circ\text{C}$	*a 14	
	$T_A=25^\circ\text{C}$	*b 3.2	
	$T_A=70^\circ\text{C}$	*b 2	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~+150	°C

### Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	$R_{\theta JC}$	3.7	°C/W
Thermal Resistance, Junction-to-ambient	$R_{\theta JA}$	39	

Note:

- \*a. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- \*b. The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The power dissipation  $P_D$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- \*c. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ . Ratings are based on low frequency and low duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

### Electrical Characteristics ( $T_A=25^\circ\text{C}$ , unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	-60	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA
V <sub>GS(th)</sub>	-1	-	-2.5		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
G <sub>FS</sub>	-	8	-	S	V <sub>DS</sub> =-10V, I <sub>D</sub> =-4A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	-1	μA	V <sub>DS</sub> =-48V, V <sub>GS</sub> =0V
R <sub>DSS(ON)</sub>	-	66	86	mΩ	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4A
	-	80	110		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A
<b>Dynamic</b>					
C <sub>iss</sub>	-	1400	-	pF	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	65	-		
C <sub>rss</sub>	-	50	-	Ω	f=1MHz
R <sub>g</sub>	-	24	-		
Q <sub>g</sub> *1, 2	-	25	-	nC	V <sub>DS</sub> =-30V, I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V
Q <sub>gs</sub> *1, 2	-	3.7	-		
Q <sub>gd</sub> *1, 2	-	4	-	ns	V <sub>DS</sub> =-30V, I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V, R <sub>GS</sub> =6Ω
t <sub>d(ON)</sub> *1, 2	-	7	-		
t <sub>r</sub> *1, 2	-	22	-	ns	V <sub>DS</sub> =-30V, I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V, R <sub>GS</sub> =6Ω
t <sub>d(OFF)</sub> *1, 2	-	120	-		
t <sub>f</sub> *1, 2	-	50	-		
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	-0.83	-1.2	V	I <sub>S</sub> =-4A, V <sub>GS</sub> =0V
t <sub>rr</sub>	-	12	-	ns	I <sub>F</sub> =-4A, dI <sub>F</sub> /dt=100A/μs
Q <sub>rr</sub>	-	8	-	nC	

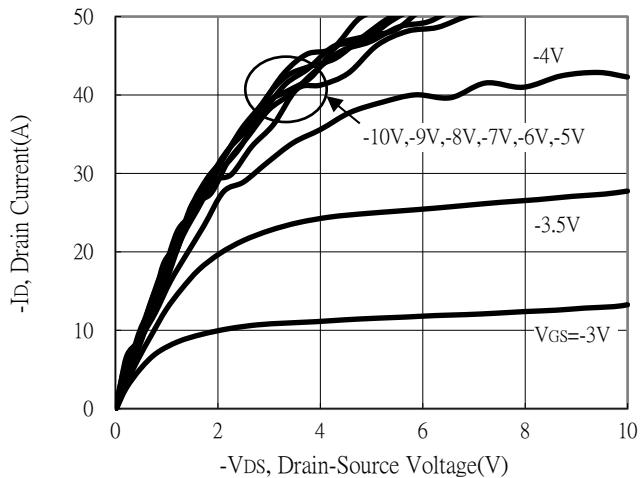
Note:

\*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

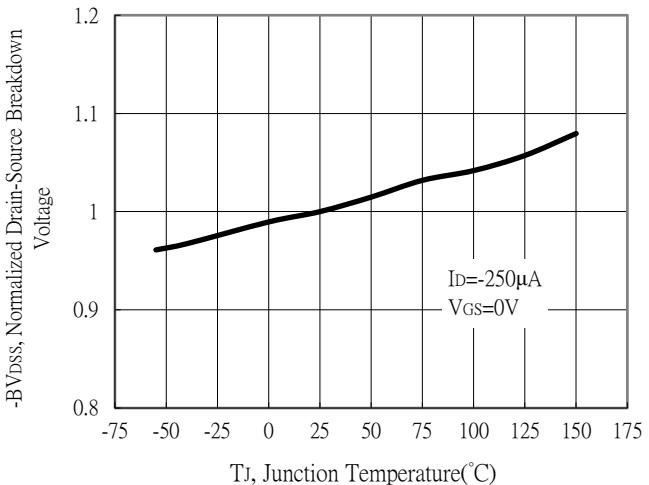
\*2. Independent of operating temperature

## Typical Characteristics

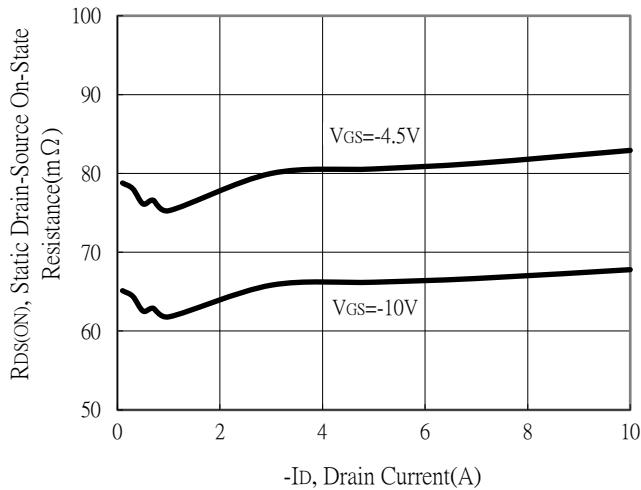
Typical Output Characteristics



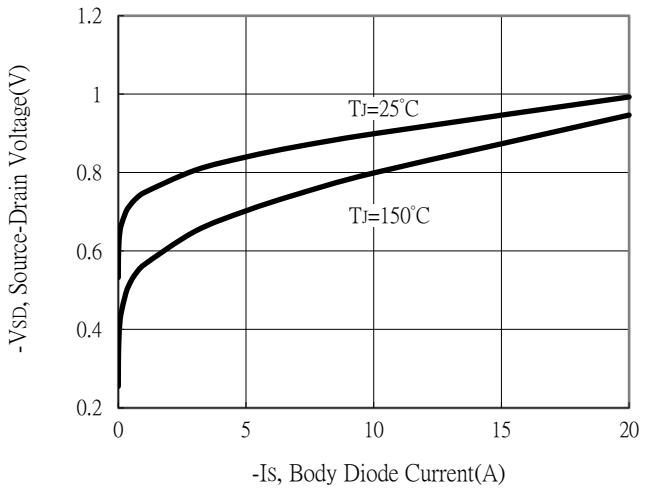
Breakdown Voltage vs Ambient Temperature



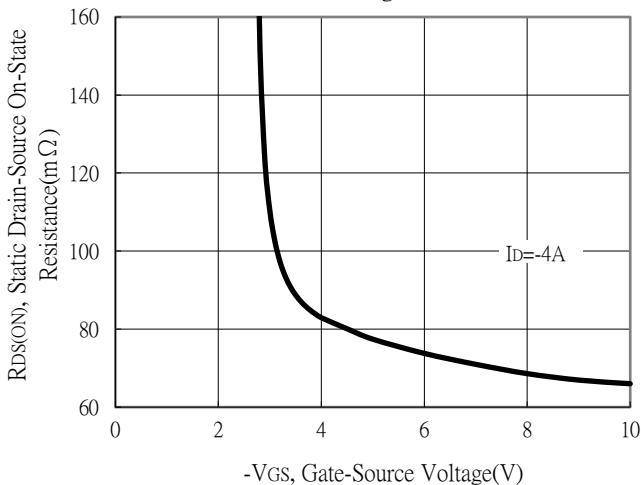
Static Drain-Source On-State resistance vs Drain Current



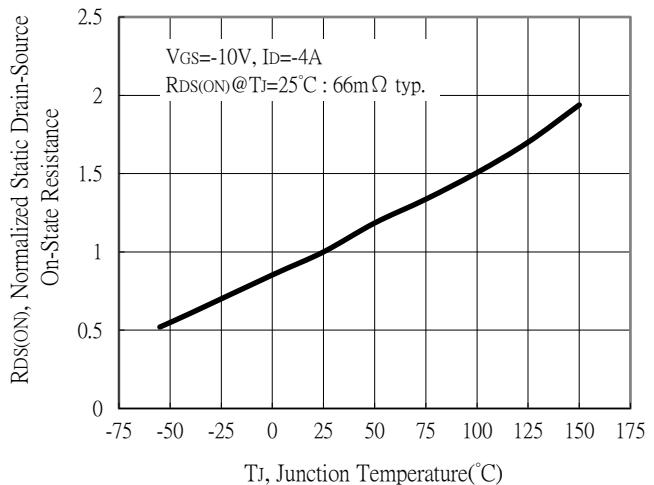
Body Diode Current vs Source-Drain Voltage



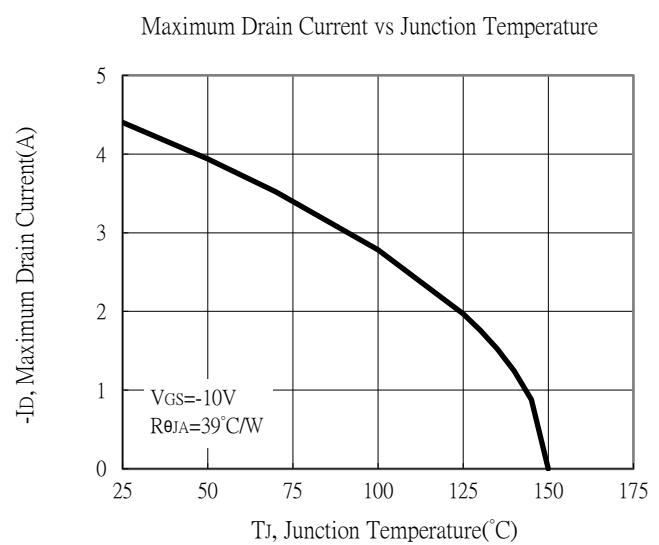
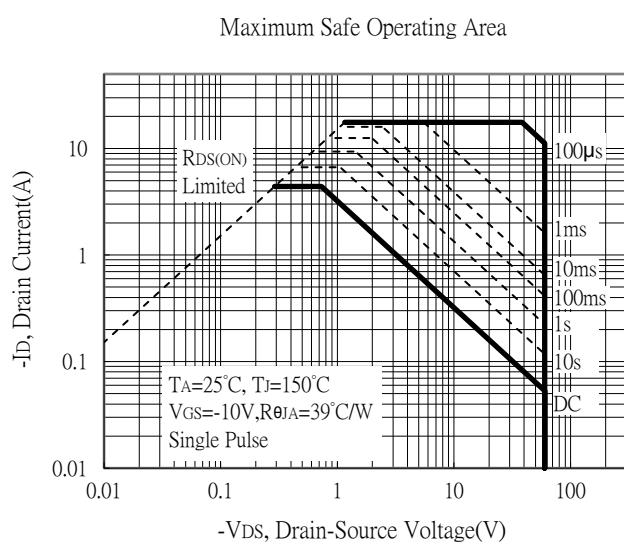
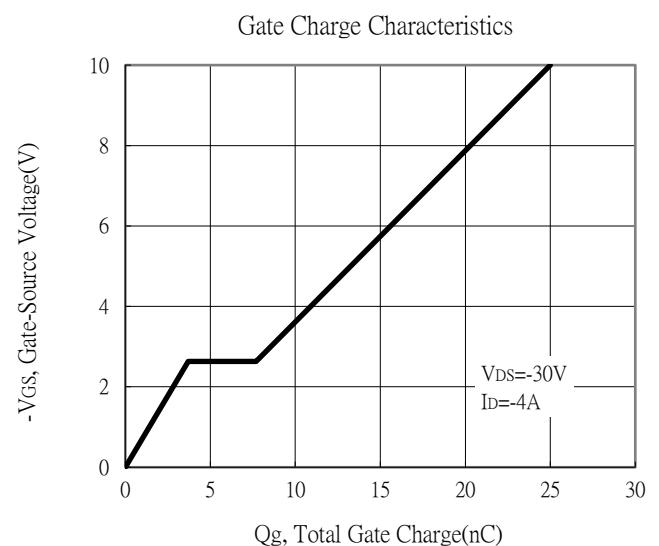
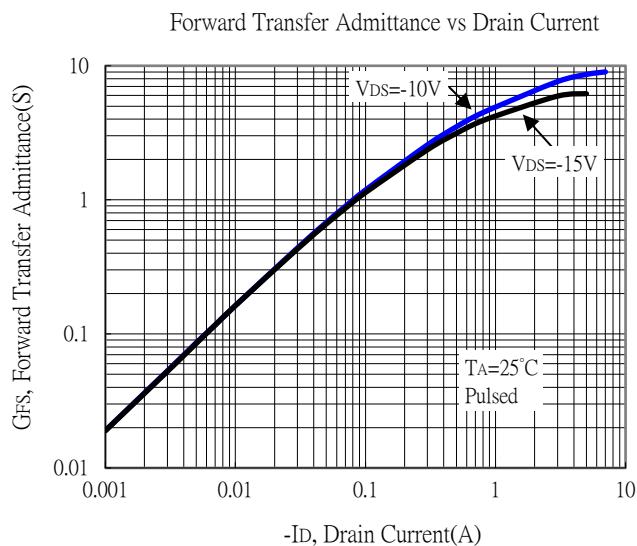
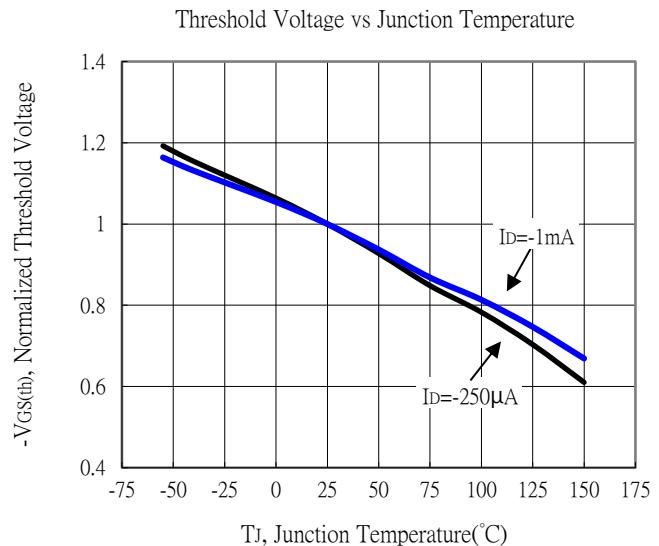
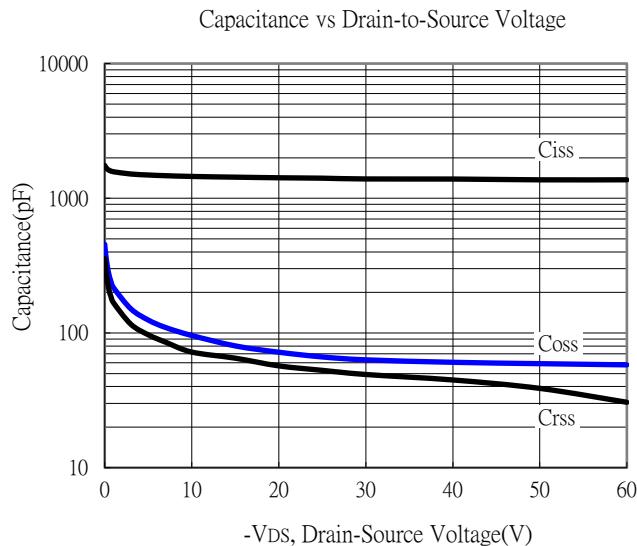
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

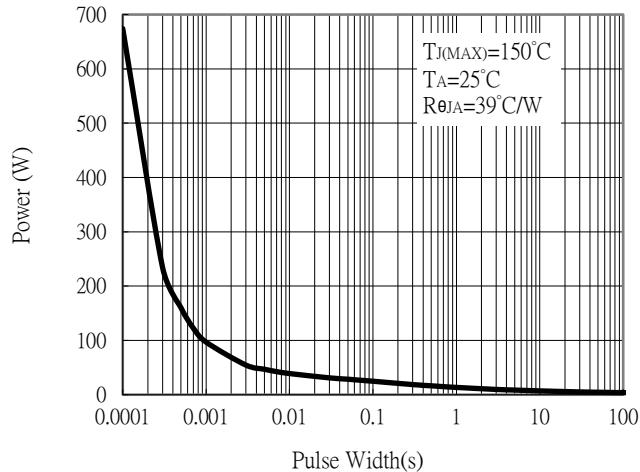


## Typical Characteristics (Cont.)

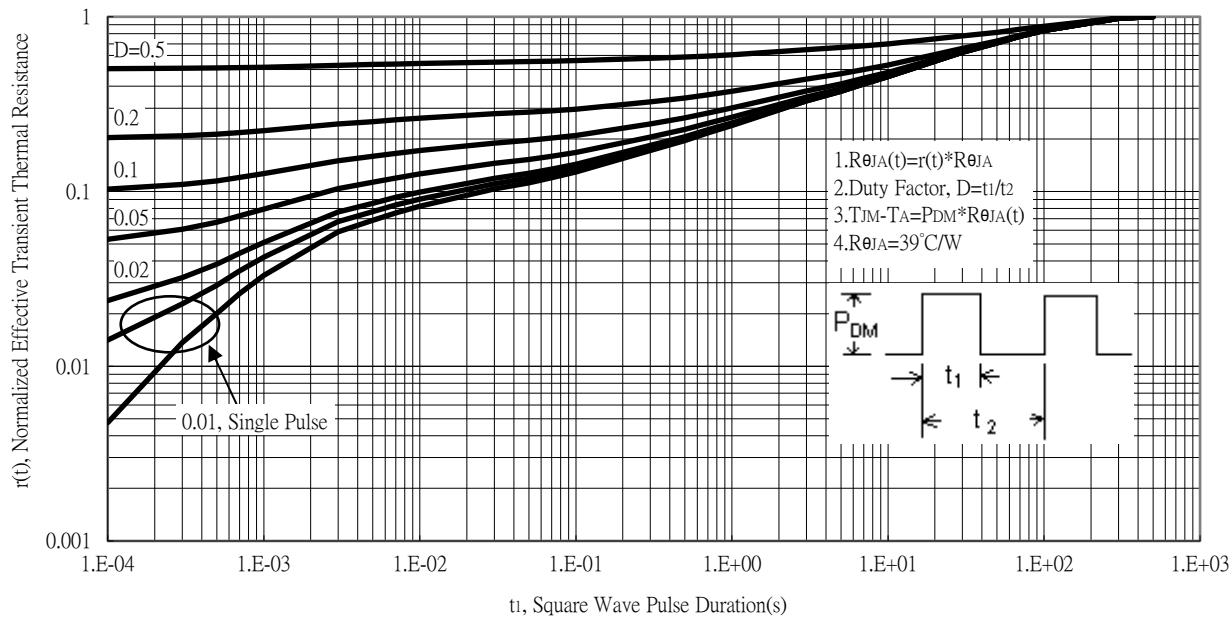


## Typical Characteristics (Cont.)

Single Pulse Power Rating, Junction to Ambient



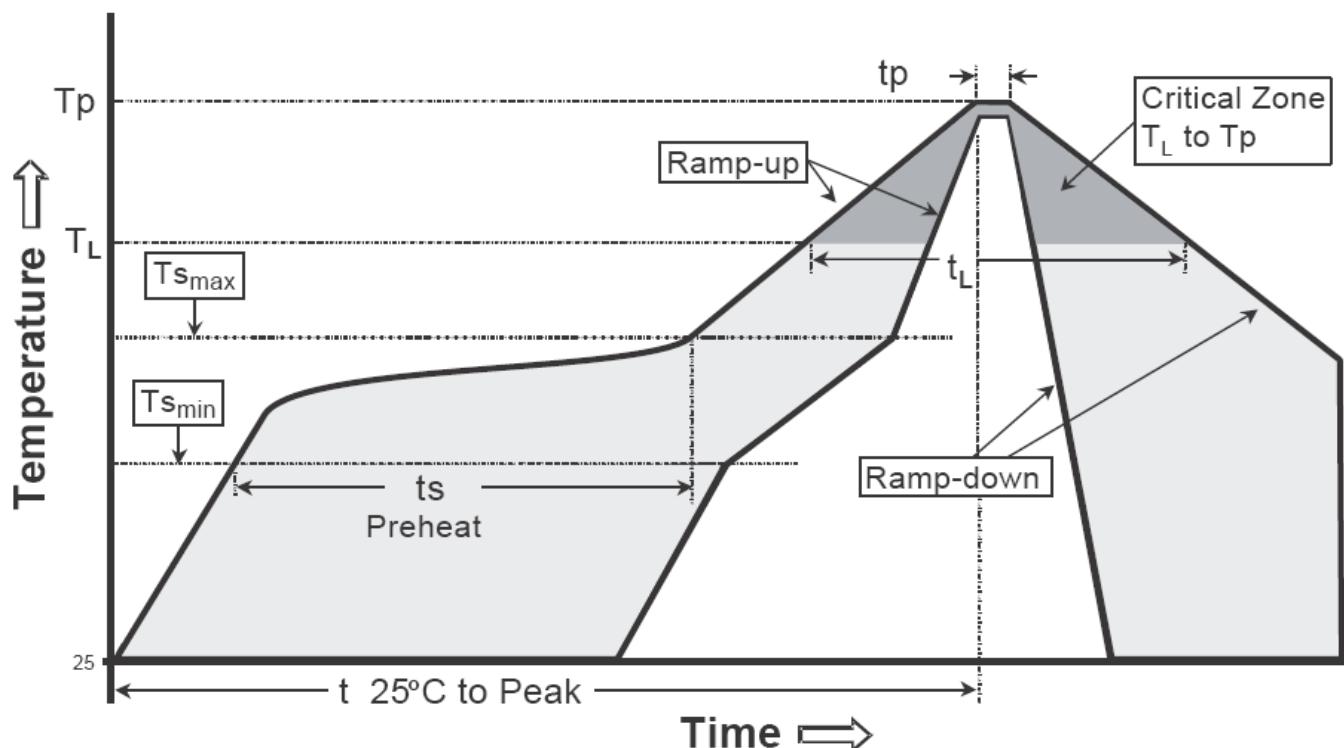
Transient Thermal Response Curves



### Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

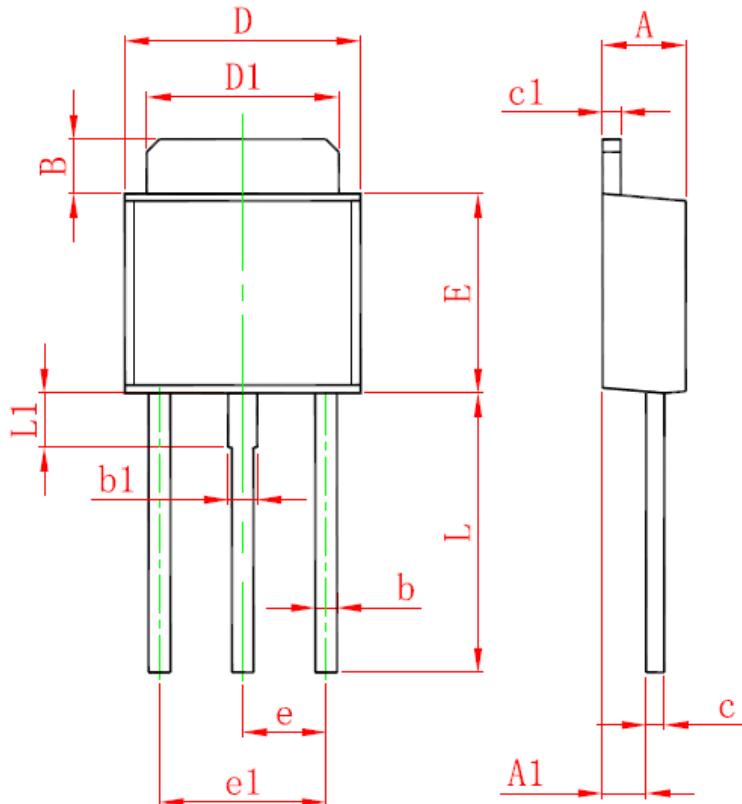
### Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate ( $T_s \text{ max}$ to $T_p$ )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min( $T_s \text{ min}$ )	100°C	150°C
-Temperature Max( $T_s \text{ max}$ )	150°C	200°C
-Time( $t_s \text{ min}$ to $t_s \text{ max}$ )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature ( $T_L$ )	183°C	217°C
- Time ( $t_L$ )	60-150 seconds	60-150 seconds
Peak Temperature( $T_p$ )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature( $t_p$ )	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

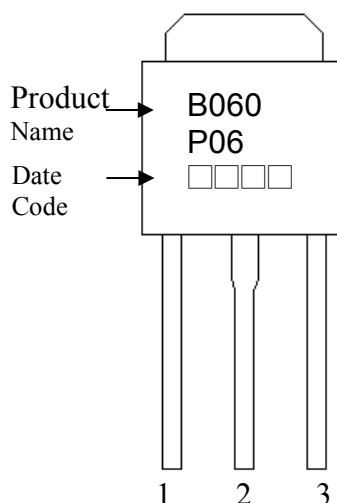
Note : All temperatures refer to topside of the package, measured on the package body surface.

## TO-251 Dimension



3-Lead TO-251 Plastic Package  
 CYStek Package Code: I3

Marking:



Style: Pin 1.Gate 2.Drain 3.Source

Date Code(counting from left to right) :

1<sup>st</sup> code: year code, the last digit of Christian year  
 2<sup>nd</sup> code : month code, Jan→A, Feb→B, Mar→C,

Apr→D, May→E, Jun→F, Jul→G, Aug→H,  
 Sep→J, Oct→K, Nov→L, Dec→M

3<sup>rd</sup> and 4<sup>th</sup> codes : production serial number, 01~99

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	2.20	2.40	0.087	0.094	D	6.35	6.65	0.250	0.262
A1	1.02	1.27	0.040	0.050	D1	5.20	5.40	0.205	0.213
B	1.35	1.65	0.053	0.065	E	5.40	5.70	0.213	0.224
b	0.50	0.70	0.020	0.028	e	2.30 TYP		0.091 TYP	
b1	0.70	0.90	0.028	0.035	e1	4.50	4.70	0.177	0.185
c	0.43	0.58	0.017	0.023	L	7.50	7.90	0.295	0.311
c1	0.43	0.58	0.017	0.023	L1	1.20	1.60	0.047	0.063

Notes: 1. Controlling dimension: millimeters.

2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.